## 2022 International Conference on Code Quality (ICCQ 2022)

Innopolis, Russia 23 April 2022



IEEE Catalog Number: CFP22Y54-POD ISBN: 978-1-6654-1204-9

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 IEEE Catalog Number:
 CFP22Y54-POD

 ISBN (Print-On-Demand):
 978-1-6654-1204-9

 ISBN (Online):
 978-1-6654-1203-2

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